## 仮想環境下における鉛はんだおよび鉛フリーはんだからの溶出挙動

原 美永子\*, 中澤 克仁\*\*, 片山 恵一\*\*\*, 坂村 博康\*, 安井 至\*

## Elution Characteristics of Lead Solder and Lead-Free Solder under Pseudo-Environments

Minako HARA<sup>\*</sup>, Katsuhito NAKAZAWA<sup>\*\*</sup>, Keiichi KATAYAMA<sup>\*\*\*</sup>, Hiroyasu SAKAMURA<sup>\*</sup> and Itaru YASUI<sup>\*</sup>

\*東京大学生産技術研究所(〒153-8505 東京都目黒区駒場4-6-1)

\*\*科学技術振興事業団 (〒332-0012 埼玉県川口市本町4-1-8)

\*\*\*東海大学工学研究科(〒259-1292 神奈川県平塚市北金目1117)

\*Institute of Industrial Science, University of Tokyo (4-6-1 Komaba, Meguro-ku, Tokyo 153-8505)

\*\* Japan Science and Technology Corporation (4-1-8 Motomachi, Kawaguchi-shi, Saitama 332-0012)

\*\*\*Graduate School of Engineering, Tokai University (1117 Kitakaname, Hiratsuka-shi, Kanagawa 259-1292)

## Abstract

The elution characteristics of lead from the printed circuit boards in the MD players were investigated, and it was confirmed that the amount of lead eluted from the printed circuit board using  $Sn_{96}$ -Ag<sub>2.5</sub>-Bi<sub>1.0</sub>-Cu<sub>0.5</sub> solder was smaller than that from the printed circuit board using  $Sn_{63}$ -Pb<sub>37</sub> solder. The elution of elements (tin, bismuth, silver, copper and lead) from five kinds of lead-free solders and the lead solder were measured under various pseudo-environments (pure water, 3.5 wt% salt solution and pH 3 acid solution). These results indicated that the amount of each element eluted from several solders was especially large under the acid solution.

Key Words: Lead Solder, Lead-Free Solder, Elution, Lead, Pseudo-Environments